

**Preliminary Amendment**

Applicant: Stephan Blaszcak et al.

Serial No.: Unknown

(Priority Application No. DE 102 01 775.1)  
(International Application No. PCT/DE03/00083)

Filed: Herewith

(Priority Date January 17, 2002)  
(International Filing Date January 14, 2003)

Docket No.: I431.108.101/FIN 317 PCT/US

Title: ELECTRONIC COMPONENT AND PANEL AND METHOD FOR THE PRODUCTION THEREOF

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**REMARKS**

This Preliminary Amendment amends the above identified Utility Patent Application filed herewith. With this Preliminary Amendment, claims 1-12 have been cancelled. Claims 13-32 have been added. Claims 13-32 remain pending in the application and are presented for consideration and allowance.

A substitute specification is included herewith. The specification contains no new matter

**CONCLUSION**

No fees are required under 37 C.F.R. 1.16(b)(c). However, if such fees are required, the Patent Office is hereby authorized to charge Deposit Account No. 500471.

Any inquiry regarding this Preliminary Amendment should be directed to Paul P. Kempf at the below-listed telephone numbers.

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The Examiner is invited to contact the Applicants' representative at the below-listed telephone number to facilitate prosecution of this application.

Respectfully submitted,

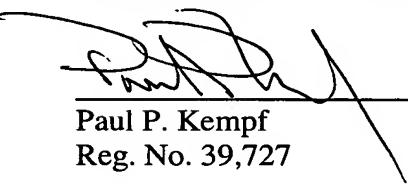
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Date: July 14, 2004

PPK:cmj

  
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I hereby certify that this is being deposited with the United States Postal Service "Express Mail Post Office to Addressee" service under 37 CFR 1.10 on the date indicated above and is addressed to: Mail Stop PCT, Commissioner for Patents, P.O. Box 1450, Alexandria, VA 22313-1450.

By Vernell Beal  
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In one embodiment of the invention, the plastic package molding compound of the first layer has in the uncrosslinked state a lower viscosity than the second layer. This has the advantage that the first, low-viscosity layer can be introduced even into narrow intermediate spaces between semiconductor chips of a closely packed leadframe or panel with many component positions in an extremely confined space by a printing technique and without any bubbles.

Since, when the leadframe or panel is divided up into individual components, the sawing track runs within the intermediate spaces, an edge protection for the semiconductor chips is consequently already produced with the first layer that is introduced into the intermediate spaces. Furthermore, it is ensured that the formation of air bubbles is minimized in these edge regions on account of the low viscosity of the first layer of plastic package molding compound in the uncrosslinked state. A further advantage of this first layer of the plastic package molding compound with low viscosity in the uncrosslinked state is that the plastic package molding compound is so liquid that it wets the edges of the semiconductor chips and, in the case of small intermediate spaces between two semiconductor chips, can be introduced into the intermediate space without any bubbles on account of capillary forces.

A further advantage of the In addition, this first layer of the plastic package molding compound with low viscosity in the uncrosslinked state is that the has a surface made of this plastic package molding compound that is extremely smooth and planar.

Consequently, an almost planar boundary phase can form between the low-viscosity first layer and a high-viscosity second layer. Since all the intermediate spaces between the semiconductor chips on a wiring board are already filled by the first, low-viscosity layer, and differences in height are

leveled out, when the second, high-viscosity layer is applied in the uncrosslinked state, an extremely planar and smooth boundary layer can be produced between the two layers without the formation of air inclusions.

5        In a further embodiment of the invention, the viscosities of the first and second layers in the uncrosslinked state differ in such a way that the viscosity of the first layer is lower by at least an order of magnitude than the viscosity of the second layer. \_On account of this clear difference in viscosity, the first layer is so liquid that it can penetrate without any problem and without air bubbles into  
10      extremely narrow intermediate spaces between semiconductor chips, and can consequently wet the edge regions of the semiconductor chips with any plastic molding compound and protect them in the crosslinked state.

15      A further aspect of the invention relates to a panel with a number of component positions for electronic components. \_The panel has a leadframe, which has in each component position a bonding channel opening which is filled with a plastic covering compound. \_The panel has on the opposite side from the bonding channel a number of spaced-apart semiconductor chips in the component positions. \_The intermediate spaces of these semiconductor chips are  
20      filled with a first layer of plastic package molding compound and the back sides of these semiconductor chips are covered with a second layer of plastic package molding compound. \_In this case, the plastic package molding compound of the first layer in the uncrosslinked state differs from the plastic package molding compound of the second layer in that the first layer in the uncrosslinked state has  
25      a lower viscosity than the second layer.

30      This construction of the panel allows it to be cast or printed for a number of components simultaneously with a first layer of lower viscosity and then the back sides of the semiconductor chips can be covered with a high-viscosity layer completely and without air bubbles, and at the same time with dimensional

stability. Only after both layers have been applied in an uncrosslinked state can there follow a temperature step, in which both plastic package molding compounds, both of the first layer and of the second layer, crosslink while maintaining a boundary phase between the two layers.

5

This boundary phase is demonstrably evident in microscopically small regions, both on the panel and on the individual electronic component, from micrographs of the plastic package molding compound. In this connection, microscopically small is understood as meaning a scale which lies in the micrometer range, dimensions only being ascertainable under an optical microscope.

10

The viscosities of the first layer and of the second layer of the panel differ by at least an order of magnitude, so that the first layer can fill the intermediate spaces between the semiconductor chips of a panel without any bubbles even when there is extremely dense packing of the panel. With a high-viscosity second layer, which then finds a relatively planar boundary area or surface, a further and dimensionally stable plastic package molding compound can be applied by a printing technique without any air bubbles. The advantage of such a panel is that, for a number of components at the same time, a plastic package molding compound comprises two components, that is a low-viscosity component and a high-viscosity component, which form a plastic package without any air bubbles.

15

20  
25 AOne method for producing the panel from a leadframe for a number of electronic components in corresponding component positions with semiconductor chip, which are encapsulated by two layers of a plastic package molding compound, has the following method steps:

=

—provision of a leadframe with a number of component positions which have a bonding channel opening at their center,

—application of a double-sided adhesive film with a bonding channel opening in the component positions,

5 —application of semiconductor chips with their active upper sides to the double-sided adhesive film,

—introduction of bonding connections in every bonding channel for electrically connecting contact areas of the semiconductor chip to external contacts on the underside of the leadframe,

10 —filling of the bonding channel with a plastic covering compound,

—printing of a first layer of low-viscosity plastic package molding compound onto the back sides of the semiconductor chips for filling the intermediate spaces between the semiconductor chips on the leadframe,

15 —printing on of a second layer of high-viscosity plastic package molding compound for covering the back sides of the semiconductor chips,

—curing of the plastic package molding compound to form a closed upper side of the panel with the formation of a boundary phase,

—application of external contacts to the underside of the panel.

With

20 This method has the advantage that many steps on the way to producing an electronic component can be carried out in parallel for a number of electronic components. In addition, with this method has the advantage that the intermediate spaces between the semiconductor chips, and consequently the packing density of the semiconductor chips on the leadframe of the panel, can be made to be extremely close, since no evacuation of the intermediate spaces between the semiconductor chips is required, but rather the low-viscosity component of the first layer in the uncured state can fill the intermediate spaces between the semiconductor chips without any bubbles by means of capillary action.

Furthermore, ~~this method has the advantage that~~, with the first, low-viscosity layer, an extremely planar boundary phase can be built up between the first layer and the second layer, so that when the high-viscosity layer is applied no air bubbles are introduced into the boundary layer between the low-viscosity layer and the high-viscosity layer. The curing of the two plastic package molding compounds of the first layer and of the second layer can take place simultaneously in an annealing oven, so that a closed smooth and planar upper side of the panel is produced. Application of external contacts to the underside of the panel on each of the external contact areas of the underside of the leadframe ~~has the further advantage provides~~ that a high number of external contacts can be soldered in on the underside of the leadframe at the same time and by one step.

In an example of how the method of the invention is carried out, the printing on of the first and second layers of low-viscosity and high-viscosity plastic package molding compound takes place by means of screen printing. For this purpose, a screen which has an opening of the same size as the entire panel is placed onto the leadframe and a low-viscosity plastic package molding compound is introduced and distributed with the aid of a spatula. In this case, the plastic package molding compound is introduced into the intermediate spaces between the semiconductor chips partly by means of capillary forces, without the formation of air bubble inclusions.

Both when printing on the first layer of low-viscosity plastic package molding compound and when printing on the second layer of high-viscosity plastic package molding compound, a spatula is used, and is pressed onto the printing screen under pressure in order to produce the most uniform and planar outer surfaces possible of the electronic component or outer surfaces of the package of the electronic component.

In a further example of how the method is carried out, the second layer of plastic package molding compound, which is applied to the back sides of the semiconductor chips, may be applied with the same printing screen as the first layer of plastic package molding compound. These method steps create a panel 5 for a number of electronic components, which has a complete plastic package of plastic package molding compound on one side, this package comprising two layers lying one on top of the other which are introduced in an advantageous way without any air bubbles, because the first layer consists of a low-viscosity plastic package material and the second layer is made up of a high-viscosity 10 material. The high-viscosity covering of the back sides of the electronic semiconductor chips at the same time brings about the effect that the planar surface which is produced by a screen during the printing operation can be retained in a dimensionally stable form during the entire process phases, in particular also during the curing process.

15 A method for producing an electronic component from the panel merely has one further step to follow, that is dividing up the panel into individual electronic components. For this purpose, a saw is used to divide up the panel through the intermediate spaces, which are in the meantime filled with low-viscosity plastic, so that, if the external contacts have already been applied to the 20 panel in advance, a complete electronic component is provided, for attachment to a higher-level circuit structure such as a printed circuit board. One advantage of this method is that it is possible to dispense with expensive vacuum printing installations and expensive high-pressure injection-molding installations for the 25 method according to the invention.

To sum up, it can be stated that the filling of the leadframe with a plastic package molding compound to form a panel for a number of electronic components can take place by coating or printing the lower-lying regions 30 between the chips with a low-viscosity and non-bubble-forming plastic package

molding compound and subsequently overprinting the entire panel with a high-viscosity plastic. This overprinting makes it possible for the individual semiconductor chips within the panel to be encapsulated without any bubbles.

5       The low-viscosity encapsulating compound or plastic package molding compound that is applied first may already be cured, or else be overprinted with a high-viscosity encapsulating compound while in the not yet cured state. The method has the consequence that it is possible to dispense with the vacuum process steps that are otherwise required in the case of vacuum printing.

10      Furthermore, for methods which provide degassing of the plastic package molding compound, the slower multiple printing and the slower degassing in a vacuum can be replaced by the faster printing processes with low-viscosity material and with subsequent high-viscosity material.

15      The spacing limitation required for the evacuation of the intermediate spaces that has to be observed in the case of the vacuum printing method is also no longer needed, so that a certain gain in surface area is made possible by closer packing of the leadframe with semiconductor chips. The sinking of the encapsulating compound when it is applied by only one method step can also be prevented by this two-stage method. One embodiment of ~~the~~ invention ~~consequently utilizes the use of~~ a combination of low-viscosity and high-viscosity plastic package molding compounds in ~~an advantageous way, in order~~ to ensure bubble-free printing of plastic packages on semiconductor chips by means of a multistage process.

25

#### Brief Description of the Drawings

30      ~~The invention is now explained in more detail on the basis of exemplary embodiments with reference to the accompanying drawings. The accompanying drawings are included to provide a further understanding of the present invention~~

and are incorporated in and constitute a part of this specification. The drawings illustrate the embodiments of the present invention and together with the description serve to explain the principles of the invention. Other embodiments of the present invention and many of the intended advantages of the present invention will be readily appreciated as they become better understood by reference to the following detailed description. The elements of the drawings are not necessarily to scale relative to each other. Like reference numerals designate corresponding similar parts.

Figure 1—showsillustrates a schematic cross-sectional view of an electronic component of a component position of a panel of an embodiment of the invention.

Figure 2—showsillustrates a basic diagram of a device for applying a first layer of a plastic package molding compound for a panel.

Figure 3—showsillustrates a basic diagram of a device for applying a second layer of a plastic package molding compound for a panel.

Figure 4—showsillustrates an extract from a flow diagram for the step-by-step production of a plastic package molding compound on a panel for a number of electronic components.

#### 25                   Detailed Description

In the following Detailed Description, reference is made to the accompanying drawings, which form a part hereof, and in which is shown by way of illustration specific embodiments in which the invention may be practiced. In this regard, directional terminology, such as "top," "bottom," "front," "back," "leading," "trailing," etc., is used with reference to the

orientation of the Figure(s) being described. Because components of embodiments of the present invention can be positioned in a number of different orientations, the directional terminology is used for purposes of illustration and is in no way limiting. It is to be understood that other embodiments may be utilized and structural or logical changes may be made without departing from the scope of the present invention. The following detailed description, therefore, is not to be taken in a limiting sense, and the scope of the present invention is defined by the appended claims.

Figure 1 shows illustrates a schematic cross-sectional view of an electronic component 1 of a component position 18 of a panel 36 of an embodiment of the invention. The reference numeral 2 identifies a semiconductor chip, which is connected by its active upper side 27 on a wiring board 3 by means of a double-sided adhesive film 26. The reference numeral 4 identifies a plastic package, which is made up of a first layer 5 of a plastic package molding compound 23 and a second layer 6 of a plastic package molding compound 23. Between the plastic package molding compounds 23, or between the first and second layers 5 and 6, there forms a boundary phase 13, which is demonstrably evident under a microscope both for the electronic component 1 and for the panel 36.

The reference numeral 7 identifies the outer sides of the plastic package 4, which in the case of this embodiment of the invention, which constructs a plastic package 4 by means of a printing technique, does not substantially differ significantly from plastic packages 4 that have been produced by means of high-pressure injection-molding processes or by means of vacuum printing processes.

In the case of the high-pressure process, such a high pressure is exerted on the plastic package molding compound that air bubbles are pressed out of the assembly, whereas in the case of the vacuum printing process air bubbles cannot

occur for the very reason that the entire printing is carried out in a vacuum chamber.

The reference numerals 8 and 9 identify the edge regions of the  
5 semiconductor chip 2, which are enclosed at least by the first layer 5 of plastic  
package molding compound 23. The reference numeral 10 identifies the back  
side of the semiconductor chips 2 or the semiconductor chip 2, which is  
completely covered with plastic package molding compound 23, the greatest  
proportion of this plastic package molding compound 23 being provided by a  
10 high-viscosity plastic molding compound, which is applied in a second step to  
the back sides 10 of the semiconductor chips 2, to form a second layer 6. The  
reference numeral 11 identifies a closed upper side of the panel 36, which is  
substantially the upper side of the plastic package molding compound 23 of the  
second layer 6.

15 With the reference numeral 12, the intermediate spaces between the  
semiconductor chips 2 of a panel 36 are identified. These intermediate spaces 12  
may be made extremely narrow, since the low-viscosity plastic package molding  
compound 23 in the uncrosslinked state can penetrate into very narrow  
intermediate spaces 12 by means of capillary action. ~~This has the advantage that~~  
20 ~~In this way,~~ the packing density of the semiconductor chips 2 on a leadframe 20  
can be increased and improved. The reference numeral 13 identifies the  
boundary phase, already mentioned above, between the first, low-viscosity layer  
5 and the second, high-viscosity layer 6 of plastic package molding compound  
25 23.

30 Arranged on the underside 21 of the leadframe 20, opposite from the  
plastic package molding compound 23, is a bonding opening 14 for a bonding  
channel 15. ~~This bonding channel 15 is required to allow~~ the microscopically  
small contact areas 34 of the semiconductor chip 2 to be connected to the

macroscopic external contacts 30 on the wiring board 3. For this purpose, bonding connections 16 are arranged between the contact areas 34 of the semiconductor chip 2 and the wiring leads 19 on the underside of the leadframe 20. The wiring leads 19 extend from the bonding channel 15 to external contact areas 30 on the underside of the wiring board 3. These external contact areas 30 carry external contacts 22, which are arranged on the external contact areas 30 on the underside 21 of the leadframe 20.

At the transitions of the bonding connections 16 to the wiring leads 19, they have bonding ends or bonding fingers. These bonding ends may be improved by a coating. Since the wiring leads 19 substantially comprise a copper layer, a copper-diffusion-inhibiting metal and a precious metal arranged on top of the latter may be provided for the improvement. The copper-diffusion-inhibiting metal may be nickel or alloys of the same, since copper cannot diffuse through this nickel layer. The precious metal layer may consist of gold, silver or alloys of the same and provides frictionless bonding. By applying a flux to the external contact areas 30, external contacts can also be soldered onto the external contact areas 30.

The sensitive bonding connections 16 may be protected by filling the bonding channel 15 with a plastic covering compound 17. In this case, the height of the plastic covering compound 17 is less than the height by which the external contacts protrude from the underside of the wiring board 3 or the underside 21 of the leadframe 20. The leadframe 20 itself, which has a number of component positions 18, comprises a core plate 32, which for its part consists of glass-fiber reinforced epoxy resin.

As shown illustrated in Figure 1, the electronic component 1 has a bubble-free plastic package molding compound 23 on the semiconductor chips 2, since an inclusion of air bubbles is prevented in principle by the multistage

application of the plastic package molding compound 23 in the form of a first, low-viscosity package molding compound and a high-viscosity package molding compound applied on top of the latter.

In one embodiment,

5       The difference in viscosity between the first layer 5 of plastic package molding compound 23 and the second layer 6 of plastic package molding compound 23 is at least an order of magnitude. This ensures that the first layer 5 of plastic package molding compound 23 can be introduced into the intermediate spaces 12 between the semiconductor chips 2 without bubbles, so that the edge regions 8 and 9 of the semiconductor chip 2 are protected by a plastic package 10 molding compound 23 surrounding them. The second, high-viscosity layer 6 substantially covers the back sides 10 of the semiconductor chips 2, so that complete encapsulation of the semiconductor chips 2 is ensured by this embodiment of the invention.

15      Figure 2 ~~shows~~illustrates a basic diagram of a device for applying a first layer 5 of a plastic package molding compound 23 to a panel 36. Components with the same functions as in Figure 1 are identified by the same reference numerals and are not explained separately.

20      The device, as ~~shown~~illustrated in principle in Figure 2, has a screen 25, which leaves a screen opening 37 over the semiconductor chips 2. A spatula 24 is moved in the direction B' over the screen 25 and thereby spreads a first, low-viscosity plastic package molding compound onto the opening 37 in the screen. 25    This low-viscosity material distributes itself in the intermediate spaces 12 between the semiconductor chips 2. Since these intermediate spaces 12 can be extremely small, the filling of the intermediate spaces may, given an appropriately low viscosity, be assisted by capillary action, by which the first plastic package molding compound 23 penetrates into the intermediate spaces 30 between the semiconductor chips 2 without any bubbles.

At the same time, a pressure is exerted in the direction of the arrow A on the spatula 24, which is arranged in a mount 35, in order that the opening 37 in the screen 25 can be filled completely with the plastic package molding compound of the first layer. At the same time, part of the back sides 10 of the semiconductor chips 2 may also be printed with the low-viscosity plastic package molding compound 23.

Figure 3 ~~shows~~illustrates a basic diagram of a device for applying a second layer 6 of a plastic package molding compound 23 for a panel 36. Components with the same functions as in the preceding figures are identified by the same reference numerals and are not explained separately.

When this device is used, the intermediate spaces 12 are already filled and a spatula 24 is then moved in the direction of the arrow B, at the same time pushing a bead of high-viscosity plastic package molding compound 23 in front of it, and consequently printing a covering onto the back sides 10 of the semiconductor chips 2 in the component positions 18. This high-viscosity plastic package molding compound 23 can be applied without any bubbles, because the first layer forms an extremely planar surface as a boundary phase.

Figure 4 ~~shows~~illustrates an extract from a flow diagram for producing a plastic package molding compound 23 on a panel 36 for a number of electronic components 1. The flow diagram comprises in the ~~1st~~first stage the printing of the opening in the screen, and consequently the printing of the semiconductor chips with a low-viscosity plastic package molding compound. This low-viscosity plastic package material will become lodged in the intermediate spaces between the semiconductor chips of a panel, without air bubble inclusions occurring.

5

In the 2ndsecond stage, there is then carried out a second printing operation, in which a high-viscosity plastic package molding compound is pressed into the opening of the screen with the aid of the spatula, while applying a pressure in the direction of the arrow A to the device shownillustrated in Figure 3.

10

In the 3rdthird stage, the plastic is cured with the aid of thermal steps. For this purpose, the low-viscosity, first layer may have already been cured in advance, so that in the 3rdthird stage the high-viscosity component is crosslinked.

The 4thfourth stage comprises the dividing up of the panel into individual electronic components.